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Improving cyclic performance of Si anode for lithium-ion batteries by forming an intermetallic skin†

Xingkang Huang,^a Shun Mao,^a Jingbo Chang,^a Peter B. Hallac,^b Christopher R. Fell,^b Yanting Luo,^b Bernhard Metz,^b Junwei Jiang^b and Junhong Chen^{*a}

An intermetallic NIS_{x} coating layer was introduced on the Si surface by sputtering Ni onto Si, followed by heat-treatment. The resulting chemically bonded $NiSi_x$ layer, unlike physically coated layers that typically can crack and detach from Si surfaces upon repeated cycling, remains connected with the bulk Si as a skin-like protective surface.

Si, as an anode for lithium-ion batteries, possesses the highest theoretical capacity of 3579 mA h g^{-1} at room temperature.¹ Cyclic performance is one of the critical issues to be addressed for Si anodes prior to their practical application. The large volume changes of Si anodes upon charging and discharging lead to the pulverization of Si particles and unstable solid-state electrochemical interphase (SEI) layers.

To help construct better SEI layers, besides using electrolyte additives, forming a coating on Si surfaces is a good approach. Metal oxides $(TiO_2)^{2-5}$ Al₂O₃,⁶⁻⁸ Co₃O₄,^{9,10} and RuO₂,¹¹ *etc.*) were used to coat Si particles or thin films. For example, Lotfabad et al.² used an atomic layer deposition (ALD) to coat TiO₂ on silicon nanowires; the obtained materials show better cyclic performance compared with the pristine Si nanowires. Metals (such as Al,¹² Ag,¹³ Cu,¹⁴⁻¹⁷ and Ni¹⁷) have also been coated on Si surfaces to improve the cyclic performance of Si anodes. For example, Murugesan et al.¹⁵ synthesized Cu-coated Si particles by depositing copper on the a-Si:H particles using a polyol reduction method. Since the SEI layer on carbon is much more stable and carbon possesses a higher electrical conductivity, coating carbon on Si surfaces has been investigated intensively.¹⁸⁻²¹ For example, Wang et al.¹⁸ synthesized Si nanowires coated with carbon by thermal decomposition of ethylene. Coating conductive polymers is another choice. $22-24$ However, because of the large volume expansion of Si upon lithiation,

most of these coatings will crack, similar to what occurs to C-coated $SnO₂$ observed by high-resolution transmission electron microscopy (HRTEM).²⁵ Integration of coatings with the bulk Si can help prevent the coating layer from peeling off.

Here we report an Si anode with chemically bonded silicide surface that is expected to be more stable than a physically coated surface. To demonstrate our concept, nickel was coated on Si surfaces, followed by a heat-treatment to trigger Ni to react with the surface Si, forming a silicide coating layer. The nickel silicide is an electrochemically inactive intermetallic phase in lithium-ion batteries,²⁶⁻²⁹ but has not been deliberately designed as a protecting surface of Si anodes until now. The nickel silicide coating layer can act as a "skin" on Si and is expected to improve the cyclic performance of Si anodes. Compared with the pristine Si losing 51.8% of the reversible capacity after 50 cycles, the nickel silicide-coated Si shows significantly improved cyclic performance, for example, retaining 84.8% of the reversible capacity for a 6 nm nickel silicidecoated Si anode. COMMUNICATION

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> Experimental details are shown in the ESI.† In brief, to obtain the $N iS_i$ -coated Si, as shown in Fig. 1a, Ni was coated on

Fig. 1 (a) Schematic illustration of coating $NiSi_x$ on the surface of Si nanoparticles, in which the Si was coated with Ni by sputtering, followed by annealing to allow the Ni to react with the Si, forming the NiSix surface coating, (b) TEM image, (c) HRTEM image, and (d) SAED patterns of Si@6 nm NiSi_x.

a Department of Mechanical Engineering, University of Wisconsin-Milwaukee, 3200 North Cramer Street, Milwaukee, Wisconsin 53211, USA. E-mail: jhchen@uwm.edu b Global Technology & Innovation, Power Solutions, Johnson Controls, 5757 North Green Bay Avenue, Milwaukee, Wisconsin 53209, USA

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the surface of Si by sputtering, followed by annealing at 800 $^{\circ}$ C; the sputtered Ni reacted with the surface Si, forming the $Nisi_x$ coating layer. The morphology of Si did not change after coating with $NiSi_x$ as indicated by the scanning electron microscopy (SEM) images (Fig. S1†), nor did its bulk structure as evidenced from the X-ray diffraction (XRD) pattern of the $Nisi_x$ -coated Si that shows only Si diffraction peaks (Fig. S2†). No oxides were detected, which suggests that the oxygen content, if present, is lower than the detection limit of the instrument. However, the $NiSi_x$ coating layer can be identified by transmission electron microscopy (TEM) and high-resolution TEM (HRTEM) images of the as-prepared $N i S i_x$ -coated Si, as shown in Fig. 1b and c. The Si particles in sample $Si@6$ nm $NiSi_x$ were uniformly coated with a coating layer of approximately 6 nm in thickness. Note that while the sputtering Ni vapour may deposit on the underlayer Si particles due to the high vacuum, not all of the Si particles were coated by the exact 6 nm of N_i ; some of the Si particles were observed with a ca. 1 nm coating layer as suggested in Fig. S3.† Theoretically, the thickness of the coated Ni for sample Si@6 nm $Nisi_x$ ranges from 3–6 nm because each Si particle has the chance to be coated twice of 3 nm Ni. However, as a matter of the fact, the Si particles located below the surface have less chance to be coated. Although a uniform N_iSi_x coating is desirable to achieve the best protection for Si, the nonuniform coating layer does not compromise our main purpose in this study, namely, to demonstrate the function of the $Nisi_x$. Communication

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The d-spacing of 0.31 nm shown in Fig. 1c corresponds to the {111} diffraction planes. Because of the poor crystallinity of the coating layer, it is not possible to discern its crystallographics from HRTEM; however, we can identify the $\{202\}$ and $\{121\}$ diffraction planes of $Ni_{31}Si_{12}$ from the selected area electron diffraction (SAED) pattern (Fig. 1c). The energy dispersive X-ray spectroscopy (EDS) mapping indicates the uniform Ni distribution along with Si (Fig. 2a-c), and the EDS line scan confirms the uniform coating (Fig. 2d). Note that we did not observe an elevated Ni content on the edge of Si particle in Fig. 2d, which is likely due to the fact that Ni on the bottom side of Si surface contributes to the EDS signal since the electron beam can reach 1–3 mm in depth during EDS analysis operated at 10 kV and

Fig. 2 (a) SEM image of Si@6 nm $NISi_x$ and its corresponding EDS analysis: elemental mapping of (b) Si-Ka, and (c) Ni-L, (d) line scan of the particle shown in (a), and (e) elemental composition analysis.

Fig. 3 XPS spectra of Si $@6$ nm NiSi_x, where the peaks were corrected by C 1s at 284.8 eV.

15 mA. The Ni content in the $N iS_i$ -coated Si is ca. 4.12 wt% as suggested by the EDS analysis (Fig. 2e).

Sample Si $@6$ nm NiSi_x, for example, was characterized by X-ray photoelectron spectroscopy (XPS) as shown in Fig. 3. The peak centred at 99.9 eV is ascribed to Si in the form of elemental Si and silicide, since their binding energies are too close to be separated. The shoulder peak at 102.4 eV is associated with the surface silicon oxide because Si is prone to oxidation on the surface. The binding energy of the Ni $2p_{2/3}$ peak is centred at 853.9 eV, higher than the value belonging to elemental Ni (852.7 eV), but close to those of Ni₃Si (852.8 eV), Ni₃₁Si₁₂ (853.0 eV), Ni₂Si (853.4 eV), and NiSi (853.9 eV). $29,30$ This confirms that Ni exists in the form of silicides instead of elemental Ni. No NiO was detected as the O 1s peak of NiO is located at 320 eV, lower than the observed symmetrical peak at 532.4 eV for O 1s in our sample. The O 1s peak was ascribed to oxygen in a form of SiO_x because silicon oxide was detected as indicated by the Si 2p peak (102.4 eV).

The initial discharge capacity of pristine Si is 2881.3 mA h g^{-1} at a current density of 120 mA g^{-1} with an initial Coulombic efficiency (CE) of 90.4% (Fig. 4a). After 50 cycles at the current density of 1200 mA g^{-1} , its capacity was 882.8 mA h g $^{-1}$, 48.2% of its reversible capacity of 1832.6 mA h g $^{-1}$ at the third cycle. In contrast, the $Nisi_x$ coated samples delivered initial capacities of 2214.0, 1985.7, and 2213.4 mA h g^{-1} with initial CEs of 89.4%, 88.8%, and 89.4% for 1, 4, and 6 nm coating layers, respectively. This means that the introduction of the NiSi $_x$ coating layer decreased the capacity of the Si anode,</sub> e.g., by ca. 23% for sample Si@6 nm NiSi_x (Fig. 4b), which suggested the existence of the $Nisi_x$ coating layer because mixing 4.12 wt% of Ni will not decrease the capacity of the Si anode by 23%, whereas the increased polarization by the $Nisi_x$ will. In other words, it is more difficult for Li^+ to cross the NiSi_x coating layer compared with a conventional SEI layer. Despite the decreased initial capacity, forming a $NiSi_x$ coating layer significantly enhanced the cyclic performance of the Si anode. As shown in Fig. 4a, the capacities at the 50th cycle are 1237.4, 1123.1, and 1256.0 mA h g^{-1} , 72.3%, 74.9%, and 84.8% of the capacity at the 3rd cycle at 1200 mA g^{-1} for samples Si@1 nm $Nisi_x$, $Si@4$ nm $Nisi_x$, $Si@6$ nm $Nisi_x$, respectively.

As a comparison, we prepared a 6 nm Ni-coated Si without the subsequent heat-treatment; the as-obtained Si@Ni

Fig. 4 (a) Cyclic performance of pristine Si and NIS_{1x} -coated Si with various coating thicknesses, and (b) charge/discharge profiles of sample Si@6 nm NiSix

delivered a capacity of 3187.6 mA h g^{-1} at 120 mA g^{-1} , and retained 51.2% capacity at the 50th cycle at 1200 mA g^{-1} (Fig. S4†). As a result, while physically coating Ni slightly improved the capacity retention from 48.2% to 51.2%, the chemically bonded silicide surface is much more effective for protecting the Si during cycling, namely, resulting in up to 84.8% of the capacity retention. Note that the Si@Ni possesses a higher capacity than the pristine Si and the silicide-coated Si, which is associated with the fact that Ni metal helps improve the electrical conductivity.

Pure Si usually possesses very poor cyclic performance.^{13,31,32} For example, Yu et al.¹³ reported a commercial nanosized Si showing a capacity of ca. 3700 mA h g^{-1} while decaying to almost zero within 50 cycles. Forming surface coatings on Si was reported to improve the cyclic performance of the Si. For example, Murugesan et al.¹⁵ synthesized Cu-coated Si particles by depositing copper on the a-Si:H particles by a polyolmediated reduction of copper acetate, showing a capacity of ca. 600 mA h g^{-1} with enhanced cyclic performance. Chen et $al.$ ^{14,21} prepared C-coated and Cu-coated Si nanowire anodes, retaining 75.0% and 86.3%, respectively, of their initial capacities after 15 cycles at 0.05 C rate; in contrast, the pristine Si nanowire anode retained 63.7% of its initial capacity. Considering that very good coating layers were achieved,¹⁴ the capacity decay of these coated Si anodes is possibly due to the coating layer breaking and peeling off from the surfaces of the Si nanowires or nanoparticles. As a matter of fact, a broken C

Fig. 5 Schematic illustrations of (a) failure mechanism of the conventional coating method, taking Ni-coated Si as an example, and (b) the mechanism for the improved cyclic performance by the formation of the skin-like $NISi_x$ on the surface of Si.

coating layer on the $SnO₂$ surface was observed by an in situ TEM.³³ As shown in Fig. 5a, taking the Ni-coated Si particle as an example, the coating layer will gradually form cracks and lose electrochemical contact with Si because of the large volume change of Si upon the repeated lithiation/delithiation. Compared with such a physical coating Ni layer serving as a "jacket" layer, our $Nisi_x$ coating layer was formed by a reaction of the Si surface with the coated Ni; consequently, the asobtained chemical coating layer acts as a "skin" layer. When the $N i S_i$ -coated Si is charged, it may expand and crack somehow, but it will not peel off and lose contact with Si as shown in Fig. 5b.

Fig. $55\dagger$ shows SEM images of the Si ω 6 nm NiSi_x electrode after 50 cycles; no cracks were observed on the particles, which may be due to the Si particle size smaller than 150 nm, a critical size below which Si would not crack upon lithiation.³⁴ In addition, the SEI layer on the surface of the Si particles may disturb the observation of the nickel silicide coating layer. However, we still can find that the Ni is well distributed on the surface of the Si particle by EDS mapping (Fig. S6†). Note that some big cracks were observed on the electrode (not on the Si particles; Fig. S5†), which can explain why the silicide-coated Si anode still show decay. As a matter of fact, coating an active or inactive layer on the Si particle cannot reduce the volume change of Si upon lithiation, namely, formation of $Li_{3.75}Si$ will anyway lead to the volume expansion of Si up to \sim 300%. The strain between the particles due to the repeated expansion and contraction of the Si upon lithiation/delithiation eventually resulted in the cracks on the electrode. Nevertheless, the formation of the silicide coating layer did improve the cyclic performance of the Si anode, as discussed above, because the stable chemically bonded silicide coating layer can prevent the SEI layer from growing upon cycling.

Because sample Si@6 nm $NiSi_x$ showed the best cyclic performance among the three $NISi_x$ coated samples, we took this sample as an example to investigate the mechanism of the improved cyclic performance. Fig. 6a shows CV curves of sample Si@6 nm NiSi_x, recorded at a scan rate of 0.05 mV s⁻¹. During the initial cathodic scan, a current peak emerged at 0.19 V, followed by another developmental peak below 10 mV, corresponding with lithiation of Si to various Li_xSi phases. When potentials were swept anodically, there were two peaks at

Fig. 6 (a) CV curves, (b and c) Nyquist plots at various states of charge, in which discrete points and solid lines represent the experimental data and the fitting results, and (d) Bode plot (discrete points) and their peak fitting results (solid lines). Note that the three highest-frequency points were removed during fitting because they are not very stable; including the three points will increase the fitting error significantly.

0.36 and 0.51 V due to the delithiation of the Li_xSi . The CV behaviour is very similar to our previously reported Si/Ni composite.²⁹ Note also that the gradual development of cathodic and anodic peaks was commonly observed in CV curves of Si anodes,³⁵⁻³⁷ which is due to the gradual activation of Si.

Fig. 6b and c shows the electrochemical impedance spectroscopy (EIS) Nyquist plots of the $Nisi_x$ -coated Si anode. To reach a fully charged state, the anode was charged to 1.5 V and maintained at 1.5 V for 1 h. After allowing the anode to rest for 1 h, the anode was measured by EIS; its Nyquist plot exhibits a semicircle at the high frequency zone, followed by an inclined line after $ca.$ 32 Hz. The semicircle represents only the resistance of the SEI layer without charge transfer resistance because the potential of the anode is 1.461 V, far away from the lithiation/delithiation potentials as indicated by the CV (Fig. 6a). The inclined line should be related to the diffusion of Li ions in the SEI layer instead of in the bulk of Si particles. This is in good agreement with our recent results on a Si/Ni composite²⁹ and a Si flower anode.³⁸

The $NiSi_x$ coated Si anode was subsequently charged at 240 mA g^{-1} (C/10) for various durations to obtain its charge transfer resistance. After charging, apparently, there are two semicircles in the Nyquist plots (Fig. 6c); however, when we analysed the Bode plot, taking the 4 h charged state as an example, we found three peaks located at ca. 5012, 126, and 1 Hz (Fig. 6d), which are associated with the SEI layer, the $Nisi_x$ coating layer, and the charge transfer, respectively. We therefore used a three time-constant equivalent circuit (Fig. $57\dagger$) to fit the Nyquist plots and summarized the results in Table S1.† Considering the resistances are typically stable at or near a half charged state,³⁸ we averaged the resistances obtained at the 4 h and 6 h charged states, which shows that the Ohmic (including electrolyte and contact resistances), SEI layer, N_i Si_x coating layer, and charge transfer resistances are 3.0, 40.0, 150.3, and 115.2 Ohm, respectively.

Compared with our previous Si/Ni composite with the resistances of the SEI layer and the charge transfer of 60.0 and 139.5 Ohm, respectively,²⁹ the present $Nisi_x$ -coated Si showed an

extra NiSi_x coating layer resistance (150.3 Ohm). Note that the capacities at 1200 mA g^{-1} at the 3rd cycles are 71.2%, 64.7%, and 62.7% of the values obtained at 120 mA g^{-1} at the 2nd cycles for samples Si@1 nm NiSi_x, Si@4 nm NiSi_x, and Si@6 nm $NiSi_x$, respectively (Fig. 4a), which means that the rate capabilities of the $NiSi_x$ -coated Si anode decreased with the increasing coating thickness. Therefore, forming a thinner $Nisi_x$ coating layer, e.g., by the ALD technique, may lead to less capacity loss while enhancing the cyclic performance of Si anodes. Although forming a $Nisi_x$ coating layer may increase the resistance and decrease the capacity, it can significantly improve the cyclic performance. Because Si possesses a theoretical capacity of 3579 mA h g^{-1} , approximately ten times that of commercial graphite anodes, it is worth improving its cyclic performance at the cost of a decreasing capacity. As a result, the formation of the NiSi_x coating layer like we designed here offers a new approach to improve the cyclic performance of Si anodes. Communication Website articles. Published on 23 April 2015. The Creation of T

In conclusion, $N iS_i$ -coated Si was synthesized by sputtering Ni on the surface of Si particles, followed by annealing at 800 $^{\circ}$ C. The sputtered Ni reacted with the surface of the Si, forming a $NiSi_x$ intermetallic coating layer. Compared with the pristine Si losing 51.8% of its reversible capacity within 50 cycles, the $NiSi_x$ -coated Si with a 6 nm coating layer retained 84.8% of its reversible capacity. The improved cyclic performance is related to strong binding of the skin-like $Nisi_x$ to the Si surface due to the chemical bonding, in contrast to relatively weak binding for a physically coated layer on Si.

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